

**Search Notes**

Application/Control No.

10/676,109

Examiner

Brian Ensey

Applicant(s)/Patent under  
Reexamination

TAKAYAMA ET AL.

Art Unit

2615

**SEARCHED**

Class	Subclass	Date	Examiner
Updated	search	9/12/2006	BE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Discussed with Sinh Tran	9/12/2006	BE